



产品规格手册
PRODUCT SPECIFICATION MANUAL

FQD3P50

P-Channel enhancement mode power MOSFET

TO-252/- 500 V, - 3 A, 3.5 Ω



深圳东为电子科技有限公司
DONGWEI ELECTRONIC TECHNOLOGY CO., LTD



Description

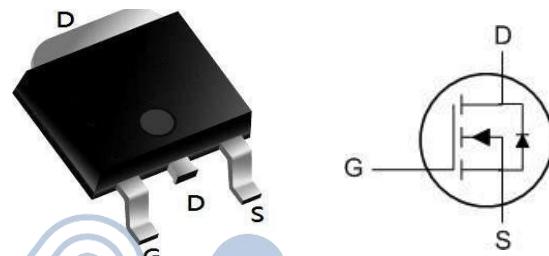
This P-Channel enhancement mode power MOSFET is produced using advanced MOSFET technology. It has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength.

Product Summary

BVDSS	RDS(on)	ID
-500V	3.5Ω	-3A

Applications

- switched mode power supplies
- active powerfactor correction (PFC)
- electronic lamp ballasts



Package Marking and Ordering Information

Product	Package	Marking	Packing	Min Unit Quantity
FQD3P50	TO-252	FQD3P50/207	2500PCS/Reel	2500PCS

Absolute Maximum

Symbol	Parameter	FQD3P50	Unit
V _{DSS}	Drain-Source Voltage	-500	V
I _D	Drain Current - Continuous (T _C = 25°C)	-3	A
	- Continuous (T _C = 100°C)	-1.33	A
I _{DM}	Drain Current - Pulsed	-8.4	A
V _{GSS}	Gate-Source Voltage	30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2) 250	mJ
I _{AR}	Avalanche Current	(Note 1) -3	A
E _{AR}	Repetitive Avalanche Energy	(Note 1) 5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3) -4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *	2.5	W
	Power Dissipation (T _C = 25°C)	50	W
	- Derate above 25°C	0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

Thermal Characteristics

Symbol	Parameter	FQD3P50	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case, Max.	2.5	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient, Max. *	50	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient, Max.	110	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Elerical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}$, $I_D = -250 \mu\text{A}$	-500	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$, Referenced to 25°C	--	0.42	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = -500 \text{ V}$, $V_{\text{GS}} = 0 \text{ V}$	--	--	-1	μA
		$V_{\text{DS}} = -400 \text{ V}$, $T_C = 125^\circ\text{C}$	--	--	-10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = -30 \text{ V}$, $V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = 30 \text{ V}$, $V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -250 \mu\text{A}$	-3.0	--	-5.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = -10 \text{ V}$, $I_D = -1.5 \text{ A}$	--	2.9	3.5	Ω
g_{FS}	Forward Transconductance	$V_{\text{DS}} = -50 \text{ V}$, $I_D = -1.5 \text{ A}$	--	2.1	--	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = -25 \text{ V}$, $V_{\text{GS}} = 0 \text{ V}$, $f = 1.0 \text{ MHz}$	--	510	660	pF
C_{oss}	Output Capacitance		--	70	90	pF
C_{rss}	Reverse Transfer Capacitance		--	9.5	12	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = -250 \text{ V}$, $I_D = -2.7 \text{ A}$, $R_G = 25 \Omega$	--	12	35	ns
t_r	Turn-On Rise Time		--	56	120	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	35	80	ns
t_f	Turn-Off Fall Time		--	45	100	ns
Q_g	Total Gate Charge		--	18	23	nC
Q_{gs}	Gate-Source Charge	$V_{\text{DS}} = -400 \text{ V}$, $I_D = -2.7 \text{ A}$, $V_{\text{GS}} = -10 \text{ V}$	--	3.6	--	nC
Q_{gd}	Gate-Drain Charge	(Note 4)	--	9.2	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	-3	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	-8.4	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}$, $I_S = -2.1 \text{ A}$	--	--	-5.0	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}$, $I_S = -2.7 \text{ A}$, $dI_F / dt = 100 \text{ A}/\mu\text{s}$	--	270	--	ns
Q_{rr}	Reverse Recovery Charge	(Note 4)	--	1.5	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 102mH, $I_{AS} = -2.1\text{A}$, $V_{DD} = -50\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq -2.7\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Essentially independent of operating temperature

Typical Characteristics

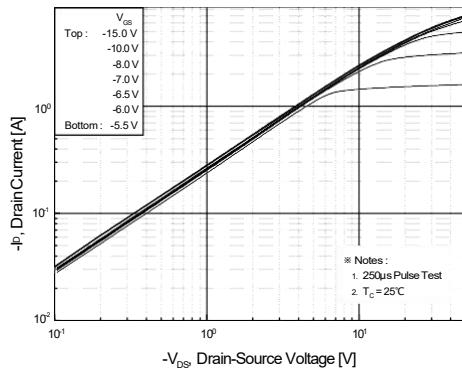


Figure 1. On-Region Characteristics

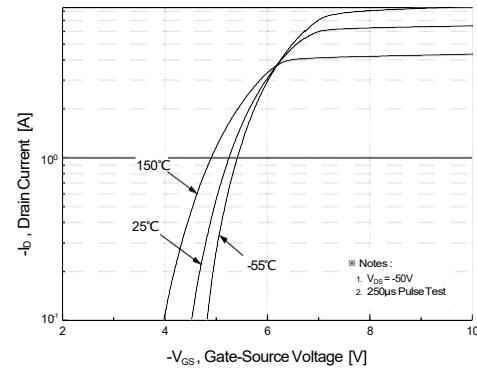


Figure 2. Transfer Characteristics

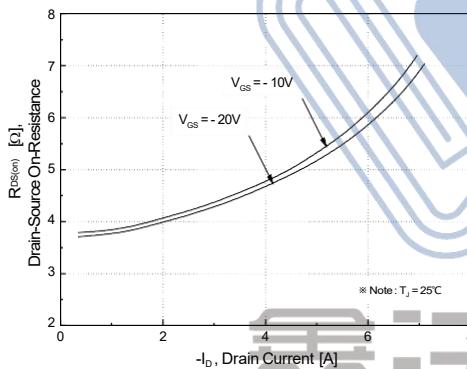


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

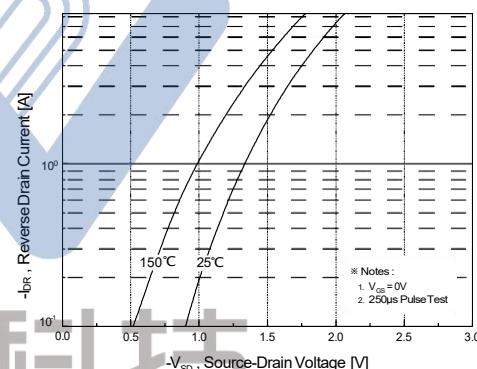


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

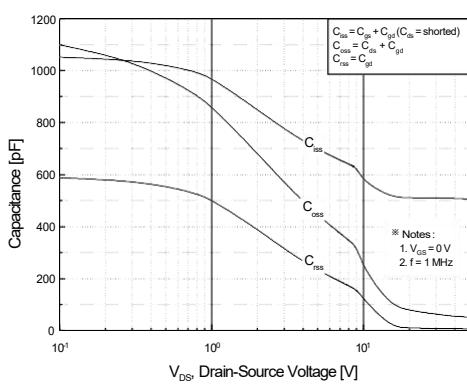


Figure 5. Capacitance Characteristics

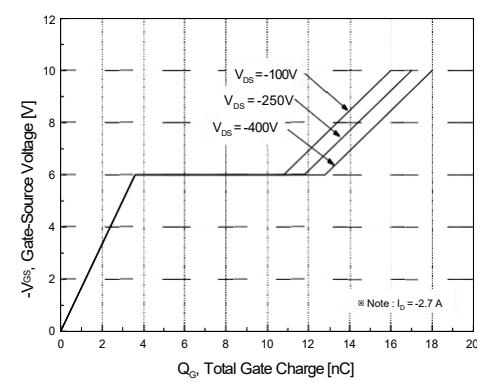


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

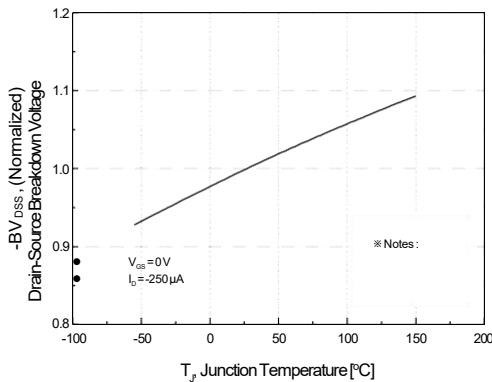


Figure 7. Breakdown Voltage Variation vs. Temperature

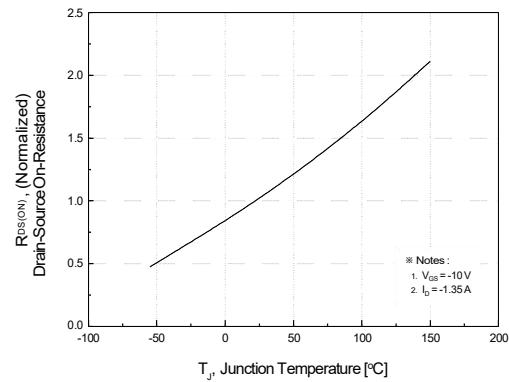


Figure 8. On-Resistance Variation vs. Temperature

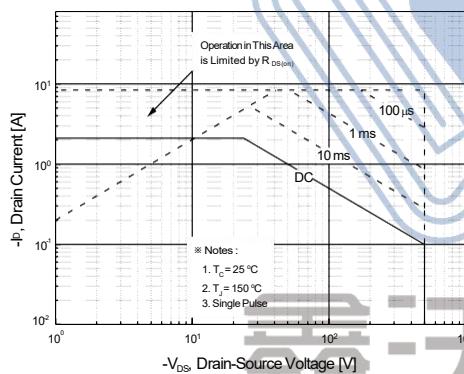


Figure 9. Maximum Safe Operating Area

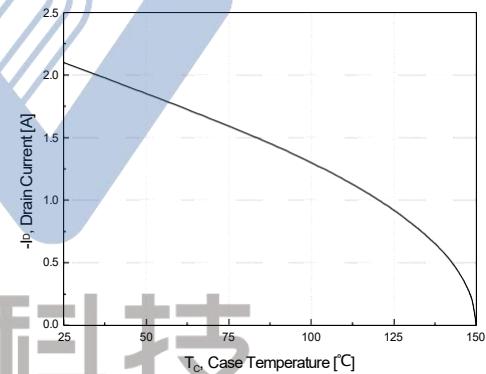


Figure 10. Maximum Drain Current vs. Case Temperature

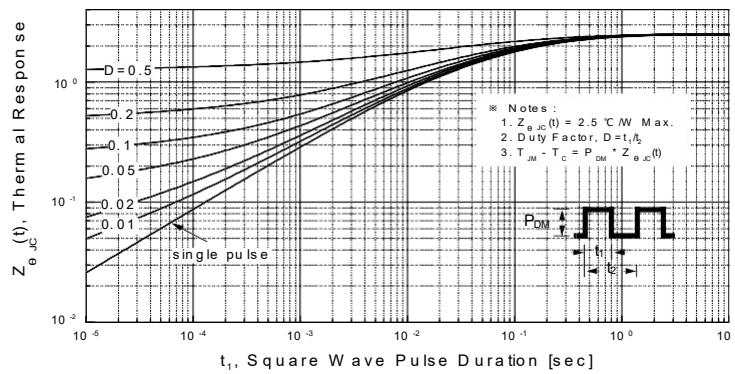
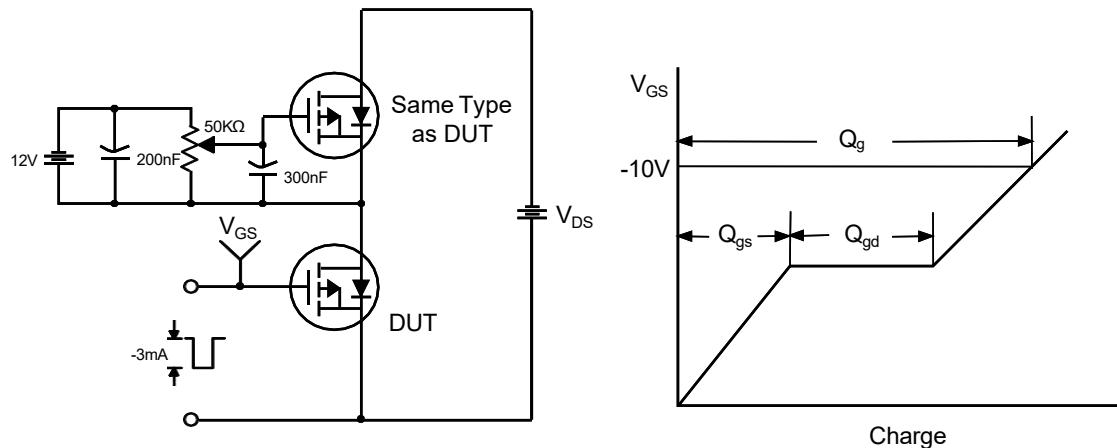
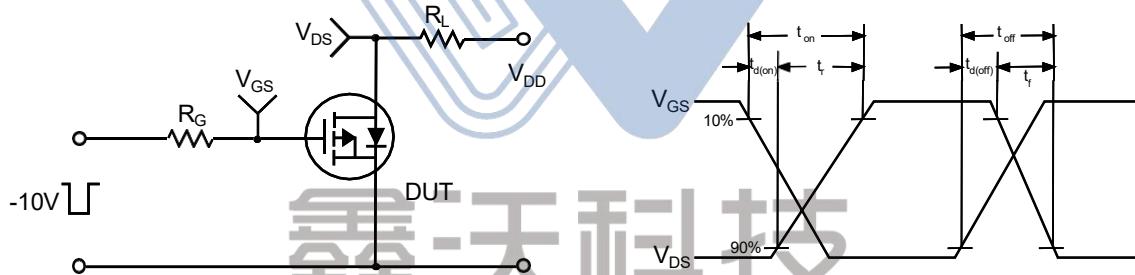


Figure 11. Transient Thermal Response Curve

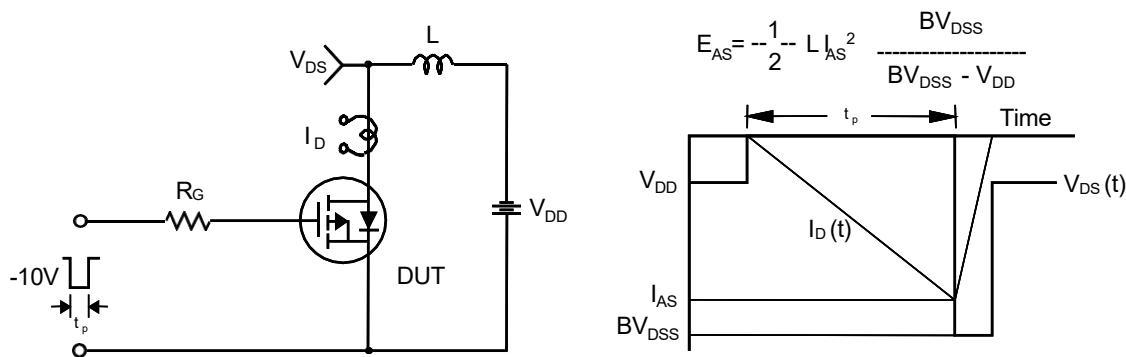
Gate Charge Test Circuit & Waveform



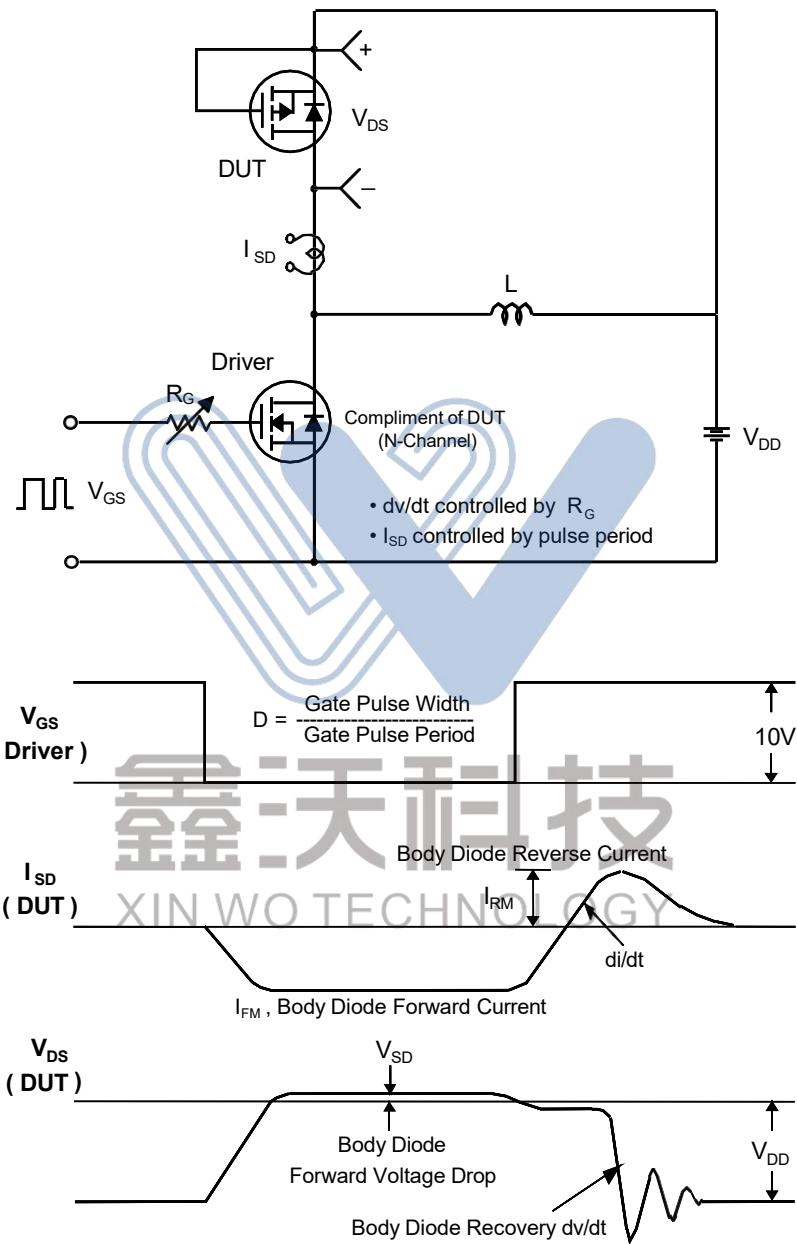
Resistive Switching Test Circuit & Waveforms



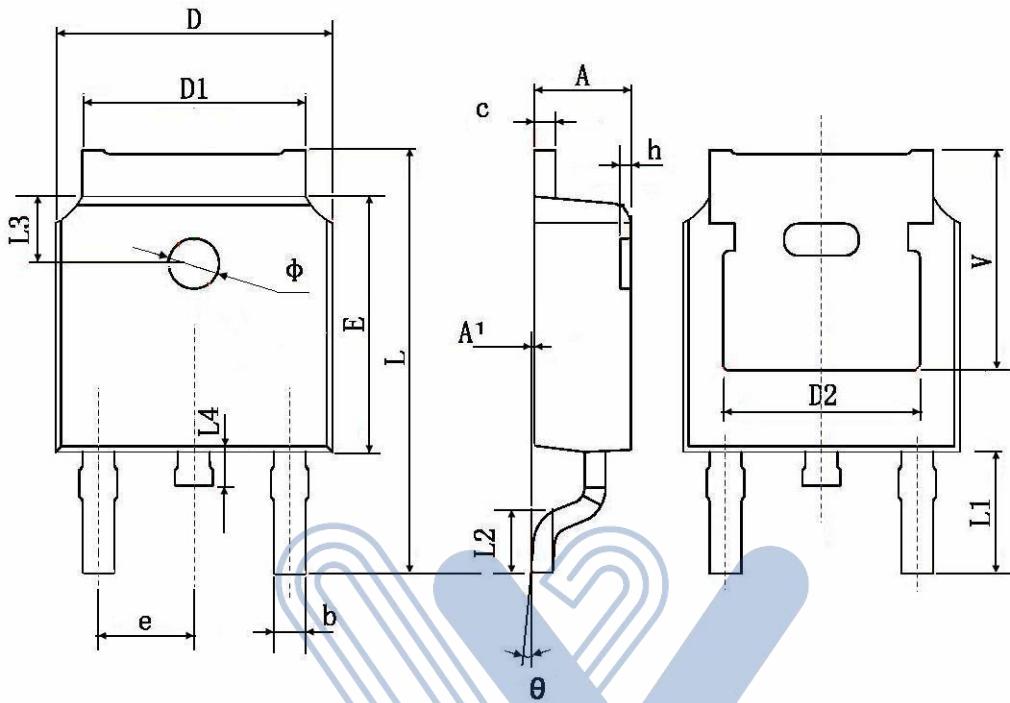
XIN WO TECHNOLOGY
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



TO252 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	0.483 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	